

INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT  
(Use several sheets if necessary)APPLICANT:  
Yamazaki, et al.FILING DATE  
November 18, 1996GROUP  
Unassigned

(37 CFR 1.98(b))

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

## FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

		DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
7	AL	JL07-43744	7/30/93	Japan				
	AM	JL07-72491	2/22/94	Japan				
	AN	JL07-120791	10/28/93	Japan				
	AO	JL07-134301	11/9/93	Japan				
	AP	JL06-160878	9/10/93	Japan				
	AQ	JL06-202073	12/28/92	Japan				
	AR	JL06-214244	1/14/93	Japan				
	AS	JL07-36058	7/20/93	Japan				
	AT	JL07-43716	7/28/93	Japan				
	AU	JP63-21907	12/25/79	Japan				

## OTHER DOCUMENTS (including Author, Title, Date, Place of Publication)

	AV	
	AW	
	AX	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

JAN 16 2001

Sheet 1 of 1

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-084002	Application No. 09/686,653
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Yamazaki et al.	
		Filing Date October 10, 2000	Group Art Unit

## U.S. Patent Documents

Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
TJ	AA	5,270,846	12/93	Watanabe et al.	349	138	
TJ	AB	5,194,976	3/93	Nakano et al.	349	138	
	AC						
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## Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

## Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature T.J.	Date Considered 03/21/01
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	